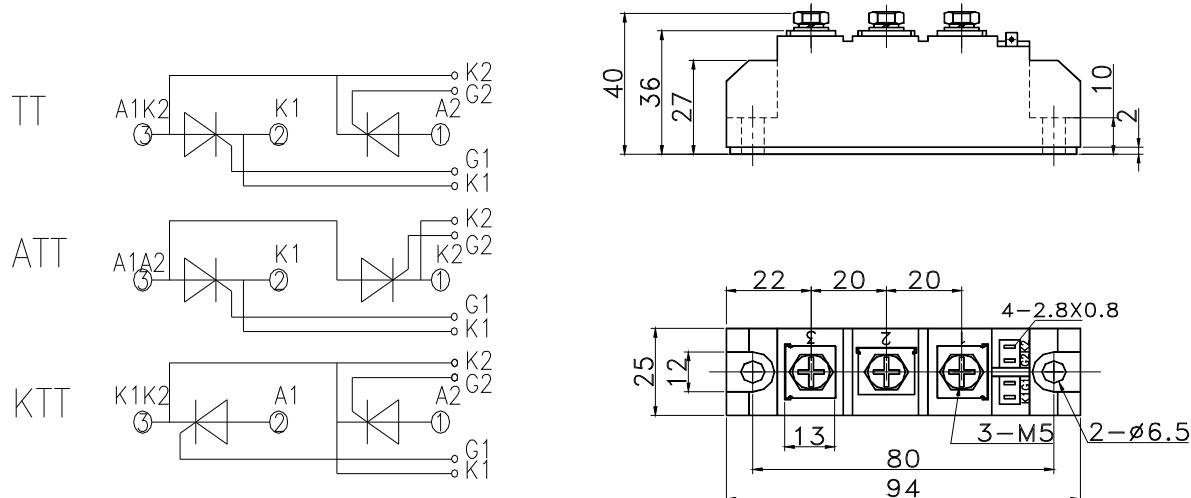


TT110 ATT110 KTT110

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	T_j (°C)	VALUE			UNIT
				Min	Type	Max	
$I_{T(AV)}$	Mean on-state current	180° half sine wave 50Hz Single side cooled, $T_c=85^\circ\text{C}$	125			110	A
$I_{T(RMS)}$	RMS on-state current	as AC switch				225	A
V_{DRM} V_{RRM}	Repetitive peak off-state voltage Repetitive peak reverse voltage	$V_{DRM} \& V_{RRM}$ tp=10ms $V_{DsM} \& V_{RsM} = V_{DRM} \& V_{RRM} + 200\text{V}$ respectively	125	600		1600	V
I_{DRM} I_{RRM}	Repetitive peak current	at V_{DRM} at V_{RRM}	125			12	mA
I_{TSM}	Surge on-state current	10ms half sine wave	125			2.40	KA
I^2t	I^2T for fusing coordination	$V_R=60\%V_{RRM}$				29.3	$\text{A}^2\text{s} * 10^3$
V_{TO}	Threshold voltage		125			0.8	V
r_T	On-state slop resistance					2.29	$\text{m}\Omega$
V_{TM}	Peak on-state voltage	$I_{TM}=330\text{A}$	125			1.69	V
dv/dt	Critical rate of rise of off-state voltage	$V_{DM}=67\%V_{DRM}$	125			800	$\text{V}/\mu\text{s}$
di/dt	Critical rate of rise of on-state current	From 67% V_{DRM} to 330A, Gate source 1.5A $t_r \leq 0.5\mu\text{s}$ Repetitive	125			100	$\text{A}/\mu\text{s}$
I_{GT}	Gate trigger current		25	30		100	mA
V_{GT}	Gate trigger voltage	$V_A=12\text{V}$, $I_A=1\text{A}$		1.0		2.0	V
I_H	Holding current			20		100	mA
V_{GD}	Non-trigger gate voltage	At 67% V_{DRM}	125			0.2	V
$R_{th(j-c)}$	Thermal resistance Junction to heatsink	At 180° sine Single side cooled				0.250	$^\circ\text{C}/\text{W}$
V_{iso}	Isolation voltage	50Hz,R.M.S,t=1min, $I_{iso}:1\text{mA}(\text{MAX})$		2500			V
F_m	Thermal connection torque(M5)				0.2		N·m
	Mounting torque(M6)				0.3		N·m
T_{stg}	Stored temperature			-40		140	$^\circ\text{C}$
W_t	Weight				160		g
Outline		202F3					

OUTLINE DRAWING & CIRCUIT DIAGRAM



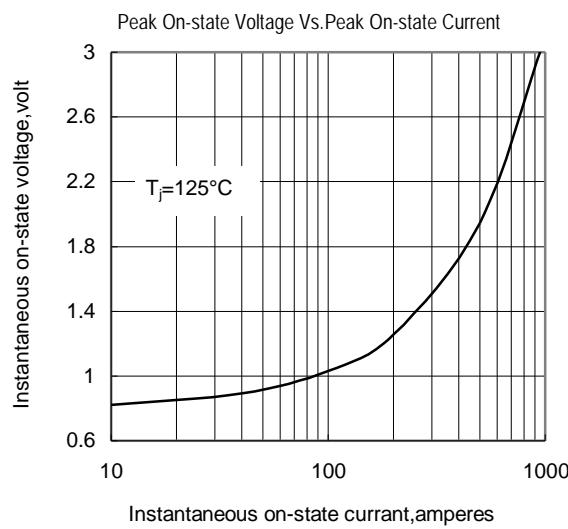


Fig.1

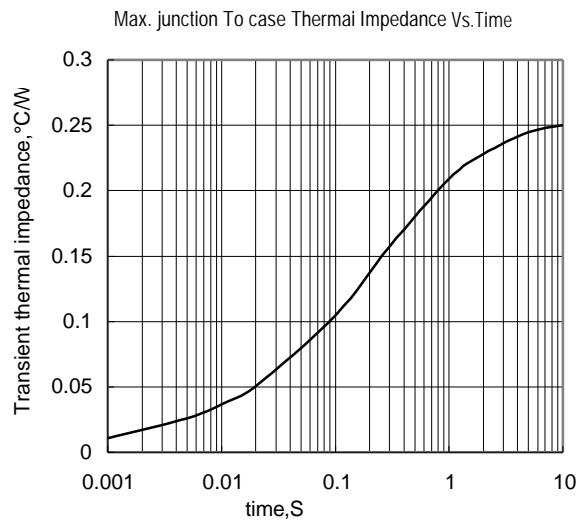


Fig.2

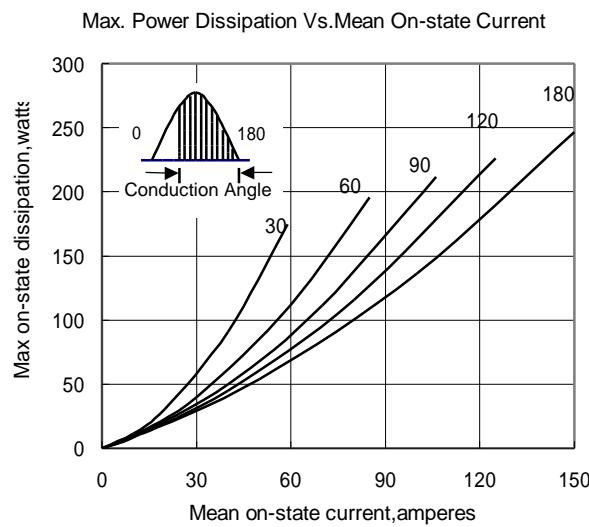


Fig.3

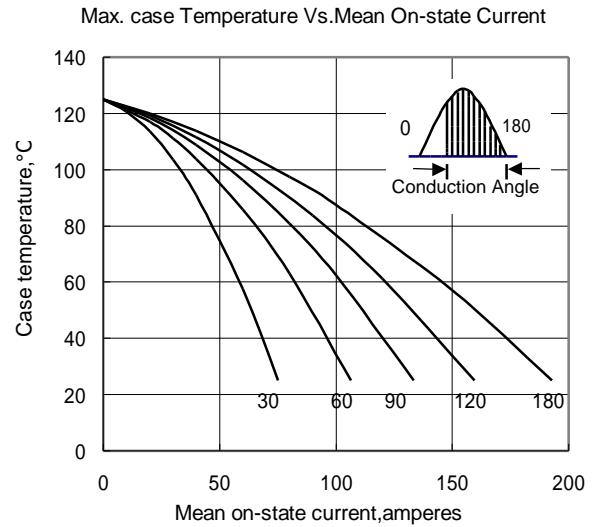


Fig.4

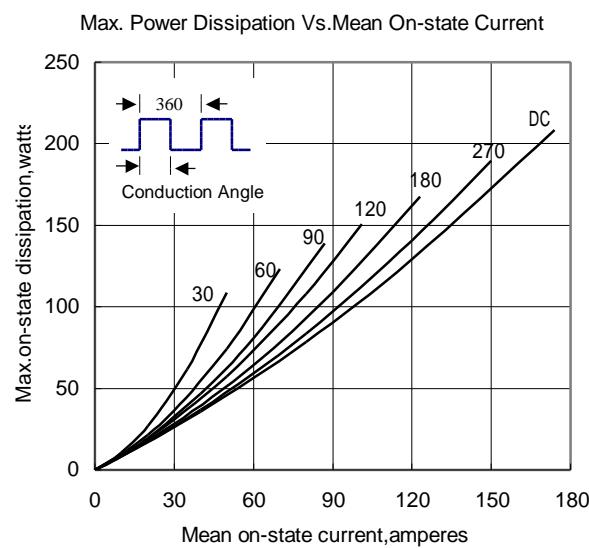


Fig.5

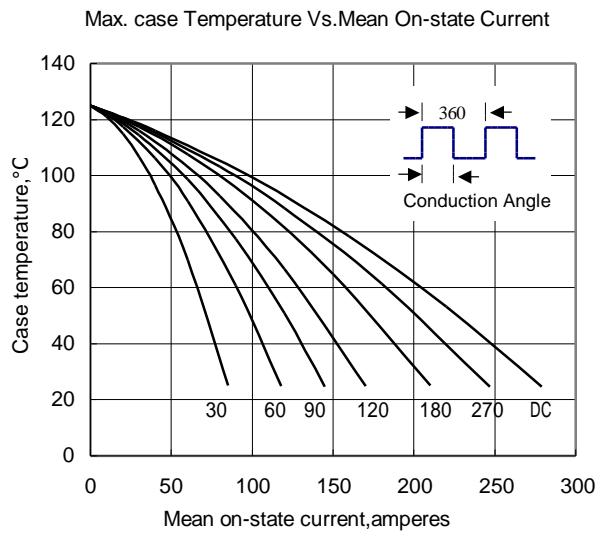


Fig.6

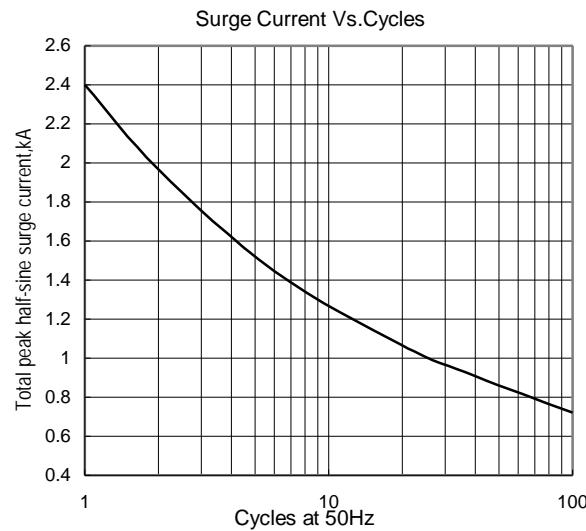


Fig.7

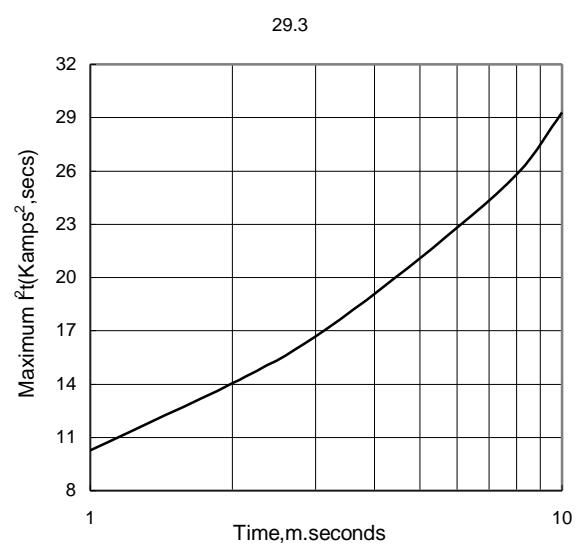


Fig.8

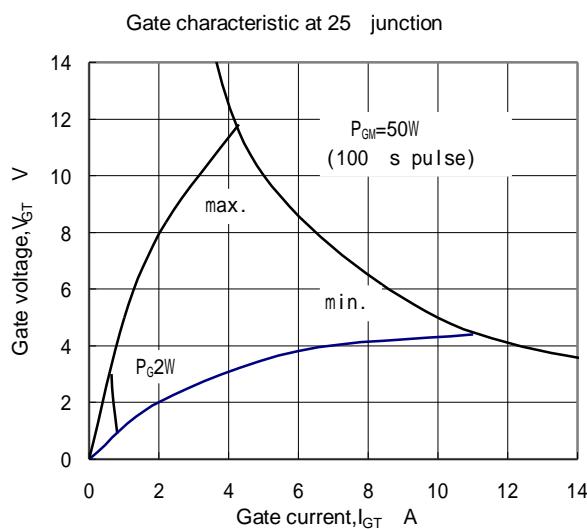


Fig.9

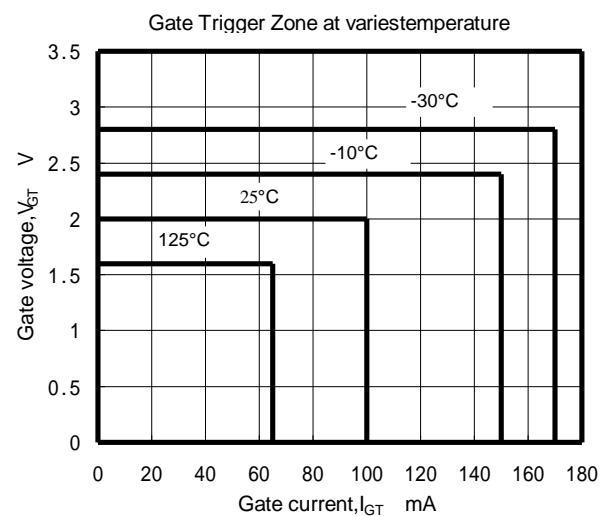


Fig.10